Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | LEE ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-2004/0155700	08-2004	Gower et al.	327/543
	В	US-2004/0036460	02-2004	Chatal, Joel	323/313
	С	US-6,407,620	06-2002	Hirayama, Nobuyuki	327/538
	D	US-6,201,436	03-2001	Hur et al.	327/543
	Е	US-6,181,121	01-2001	Kirkland et al.	323/313
	F	US-6,107,868	08-2000	Diniz et al.	327/543
	Ø	US-5,568,082	10-1996	Hedberg, Mats O. J.	327/437
	Ι	US-5,057,792	10-1991	Gay, Michael J.	323/315
	_	US-5,034,626	07-1991	Pirez et al.	327/542
	7	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
L	N					
	0			-		
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

_						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.